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EMC TEST REPORT

Report No.:	EME-070538
Model No.:	RU-87P SERIES
Issued Date:	Jun. 11, 2007

- Applicant: ICP Das Co., Ltd. No. 111, Kuangfu No. Rd., Hukou Shiang, Hsinchu, Taiwan
- Test By: Intertek Testing Services Taiwan Ltd. No. 11, Lane 275, Ko-Nan 1 Street, Chia-Tung Li, Shiang-Shan District, Hsinchu City, Taiwan

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Project Engineer

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Rico Deng

Reviewed By

Kevin Chen



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1. General Information

1.1 Identification of the EUT

Product:	ICPDAS CPU with Converter
Model No.:	RU-87P SERIES
Applicant:	ICP Das Co., Ltd.
Rated Power:	85-264Vac, 47-63Hz
Power Cord:	$3C \times 18AWG \times 1.8$ meter unshielded cable
Data Cable:	Fiber 10meter × 1
Sample receiving date:	Jun. 04, 2007
Testing date:	Jun. 06, 2007 ~ Jun. 07, 2007

1.2 Additional information about the EUT

The EUT is an ICPDAS CPU with Converter, and was defined as information technology equipment.



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The modules are listed as below:

Module	Diversity
RU-87P2	
	2 slots Remote I/O Expansion Unit (For RS-485)
RU-87P4	4 slots Remote I/O Expansion Unit (For RS-485)
RU-87P8	8 slots Remote I/O Expansion Unit (For RS-485)
M-7033	3-channel RTD Input Module
M-7033D	3-channel RTD Input Module , with LED Display
M-7041	Isolated Digital Input Module
M-7041D	Isolated Digital Input Module, with LED Display
M-7050	M-7050:Digital I/O Module
M-7050D	M-7050:Digital I/O Module , with LED Display
M-7052	Isolated Digital Input Module
M-7052D	Isolated Digital Input Module, with LED Display
M-7053	Non-isolated Digital Input Module
M-7053D	Non-isolated Digital Input Module, with LED Display
M-7060	4-channel Relay Output and 4-channel isolated Digital Input Module
M-7060D	4-channel Relay Output and 4-channel isolated Digital Input Module ,with LED Display
M-7067	Relay Output Module with Modbus protocol
M-7067D	Relay Output Module with Modbus protocol, with LED Display
M-7080	Counter/Frequency Input Module
M-7080D	Counter/Frequency Input Module, with LED Display
I-87013W	4-channel RTD Input Module
I-87017W	8-channel Analog Input Module
I-87018W	8-Channel Thermocouple Input Module
I-87018Z	10-channel Thermocouple Input Module with High Over Voltage Protection
I-87024W	4-channel 14-bit analog output module
I-87051W	16-channel Non-isolated Digital Input Module
I-87052W	8-channel Non-isolation Digital Input Module
I-87055W	16-channel Non-isolated Digital I/O Module
I-87057W	16-channel Isolated Open Collector Output Module
I-87058W	8-Channel Isolated Digital Input Module
I-87063W	8-Channel Power Relay Output Module
I-87064W	8-Channel Power Relay Output Module
I-87066W	8-channel SSR-DC Output Module
I-87068W	8-channel Relay Output Module
I-7018Z	10 channel Thermocouple Input Module with High Voltage Protection

For more detail features, please refer to user's Manual.



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1.3 Peripherals equipment

Peripherals	Manufacturer	Product No.	Serial No.
RS-232 Converter	N/A	i-7502OR	N/A
RS-485 Converter	N/A	ICP CON	N/A
Notebook PC	Compaq	DP2130	3912A556



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2. Test Summary

Emission						
Standard	Test Type	Result	Remarks			
EN 55022: 1998 +A1: 2000+A2: 2003			Pass by –26.37 dB at 0.243 MHz Line Phase			
+A1: 2000+A2: 2005 Class A	Radiated Test	PASS	Pass by –9.56 dB at 43.60 MHz With antenna polarization Horizontal			
EN 61000-3-2: 2000+A2: 2005	Harmonic current Emissions	PASS	Meet the requirements			
EN 61000-3-3: 1995 +A1: 2001+A2: 2005	Voltage fluctuation & Flicker	PASS	Meet the requirements			

Immunity (EN 55024: 1998+A1: 2001+A2: 2003)							
Standard	Test Type	Result	Performance Criteria	Test Judgment			
IEC 61000-4-2: 2001	ESD test	PASS	Criterion B	Meets the requirements of Performance Criterion A			
IEC 61000-4-3: 2002	RS test	PASS	Criterion A	Meets the requirements of Performance Criterion A			
IEC 61000-4-4: 2004	EFT test	PASS	Criterion B	Meets the requirements of Performance Criterion A			
IEC 61000-4-5: 2001	Surge test	PASS	Criterion B	Meets the requirements of Performance Criterion A			
IEC 61000-4-6: 2003	CS test	PASS	Criterion A	Meets the requirements of Performance Criterion A			
IEC 61000-4-11: 1994+A1: 2001	Dip test	PASS	 >95% reduction- Performance Criterion B 30% reduction- Performance Criterion C >95% reduction- Performance Criterion C 	Meets the requirements of Voltage Dips: 1. >95% reduction- Performance Criterion A 2. 30% reduction- Performance Criterion A 3. >95% reduction- Performance Criterion B			

Remark:

The EUT has been tested/evaluated and pass the above standards without modification.



3. Test Specifications

3.1 Standards

EN 55022: 1998+**A1: 2000**+**A2: 2003** Electromagnetic compatibility - requirements for radio disturbance characteristics of information technology equipment.

EN 61000-3-2: 2000+A2: 2005 Electromagnetic compatibility Part 3. Limits. Section 2. Limits for harmonic current emissions (equipment input current ≤ 16 A per phase)

EN 61000-3-3: 1995+A1: 2001+A2: 2005 Electromagnetic compatibility Part 3. Limits. Section 3. Limitation of voltage fluctuations and flicker in low-voltage supply systems for equipment with rated current ≤ 16 A

EN 55024: 1998+A1: 2001+A2: 2003 Information technology equipment - Immunity characteristics Limits and methods of measurement.

Remark: IEC 61000-4-8 Magnetic field immunity test The equipment does not contain components susceptible to magnetic fields, therefore, the test can be waived.

3.2 Mode of operation during the test

The EUT was supplied with 230Vac, 50Hz and was tested in normal operating mode.



3.3 Classification of ITE

ITE is subdivided into two categories denoted class A ITE and class B ITE.

Class B ITE

Class B ITE is a category of apparatus which satisfies the class B ITE disturbance limits. Class B ITE is intended primarily for use in the domestic environment and may include:

- equipment with no fixed place of use; for example, portable equipment powered by built-in batteries;
- telecommunication terminal equipment powered by a telecommunication network;
- personal computers and auxiliary connected equipment.

NOTE: The domestic environment is an environment where the use of broadcast radio and television receivers may be expected within a distance of 10 m of the apparatus concerned.

Class A ITE

Class A ITE is a category of all other ITE which satisfies the class A ITE limits but not the class B ITE limits. Such equipment should not be restricted in its sale but the following warning shall be included in the instructions for use:

WARNING

This is a class A product. In a domestic environment this product may cause radio interference in which case the user may be required to take adequate measures.



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3.4 Performance criteria

The performance criteria listed below are based on those regulated in the standard, specified by the manufacturer or derived from the product specification.

Criteria A:

During the test, the equipment shall continue to operate as intended. No degradation of performance or loss of function is allowed below performance level specified by manufacturer.

Criteria B:

Loss of function is allowed, provided the function self-recoverable or restored by the operation of the controls by the user in accordance with manufacturers instructions or after the test the equipment shall continue to operate as intended. Degradation of performance or loss of function is allowed after the application of the phenomena below a performance level specified by the manufacturer. During the test, degradation of performance is allowed. However, no change of actual operating state or stored data is allowed.

Criteria C:

Temporary degradation or loss of function or performance that requires operator Intervention or system reset.

3.5 Performance verification

The EUT has been monitored based on manufacturer's specification; the performance fulfilled the requirements of standard.



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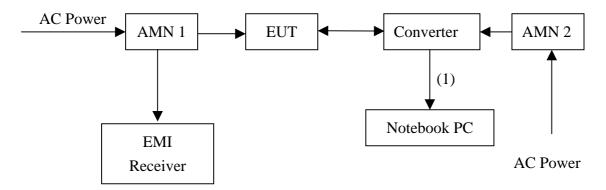
4. EN 55022 Conducted Emission Test

4.1 Mains Terminals Emission Test

4.1.1 Operating Environment

Temperature:	25		Atmospheric Pressure: 1023	hPa
Relative Humidity:	55	%	Test Voltage: 230Vac, 50Hz	

4.2 Test Procedure



(1) Fiber 10meter \times 1

The EUT along with its peripherals were placed on a $1.0m(W) \times 1.5m(L)$ and 0.8m in height wooden table and the EUT was adjusted to maintain a 0.4meter space from a vertical reference plane. The EUT was connected to power mains through a Artificial Mains Network (AMN), which provided 50 ohm coupling impedance for measuring instrument and the chassis ground was bounded to the horizontal ground plane of shielded room.

The excess power cable between the EUT and the AMN was bundled. All connecting cables of EUT and peripherals were moved to find the maximum emission



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4.3 Test Equipment

Equipment	Brand	Model No.	Intertek ID No.	Next Cal. Date
EMI Receiver	Rohde & Schwarz	ESCS 30	EC303	04/26/2008
AMN	Rohde & Schwarz	EHS3-Z5	EC320	12/19/2007
AMN	Schaffner	MN2050D	EC384	04/27/2008
Shield Room	N/A	N/A	N/A	N/A

Note: The above equipments are within the valid calibration period.

4.4 Conducted Emission Limit

Freq.	Maximum RF Line Voltage			
(MHz)	Class A	(dB µ V)	Class B	(dB µ V)
	Q.P.	Avg.	Q.P.	Avg.
0.15~0.50	79	66	66~56	56~46
0.50~5.00	73	60	56	46
5.00~30.0	73	60	60	50

4.5 Uncertainty of Conducted Emission

Expanded uncertainty (k=2) of conducted emission measurement is ± 2.26 dB.



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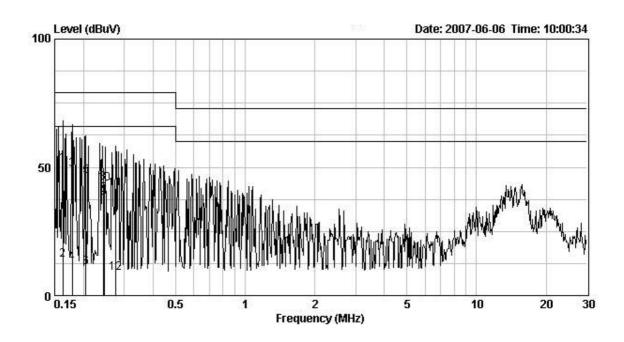
4.6 Mains Terminals Emission Data

Phase:	Line
Model No.:	RU-87P SERIES
Test Condition:	Normal operating mode

Frequency	Corr. Factor	Level Qp	Limit Qp	Level AV	Limit Av		rgin dB)
(MHz)	(dB)	(dBuV)	(dBuV)	(dBuV)	(dBuV)	Qp	Av
0.162	0.10	51.20	79.00	13.80	66.00	-27.80	-52.20
0.179	0.10	49.23	79.00	12.77	66.00	-29.77	-53.23
0.205	0.10	46.65	79.00	11.13	66.00	-32.35	-54.87
0.243	0.10	43.90	79.00	39.63	66.00	-35.10	-26.37
0.245	0.10	43.49	79.00	38.21	66.00	-35.51	-27.79
0.275	0.10	41.80	79.00	8.85	66.00	-37.20	-57.15

Remark:

- 1. Corr. Factor (dB)= AMN Factor (dB) + Cable Loss (dB)
- 2. Margin (dB) = Level (dBuV) Limit (dBuV)





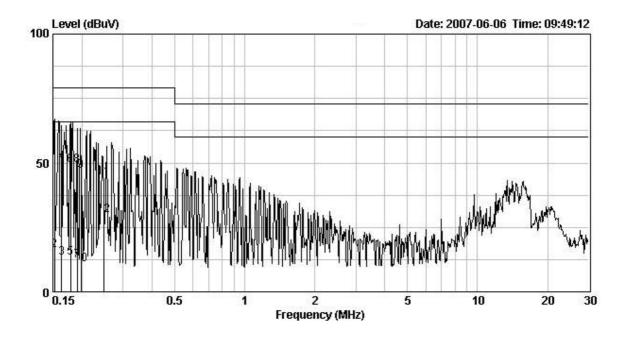
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Phase:	-	leutral					
Model No.:	K	RU-87P SERIES					
Test Condition:	N	lormal oper	rating mo	de			
Frequency	Corr. Factor	Level Qp	Limit Qp	Level AV	Limit Av		rgin dB)
(MHz)	(dB)	(dBuV)	(dBuV)	(dBuV)	(dBuV)	Qp	Av
0.152	0.10	52.59	79.00	16.29	66.00	-26.41	-49.71
0.164	0.10	50.01	79.00	13.18	66.00	-28.99	-52.82
0.179	0.10	49.23	79.00	13.29	66.00	-29.77	-52.71
0.191	0.10	49.09	79.00	12.08	66.00	-29.91	-53.92
0.198	0.10	46.75	79.00	10.55	66.00	-32.25	-55.45
0.247	0.10	44.45	79.00	29.71	66.00	-34.55	-36.29

Remark:

1. Corr. Factor (dB)= AMN Factor (dB) + Cable Loss (dB)

2. Margin (dB) = Level (dBuV) - Limit (dBuV)





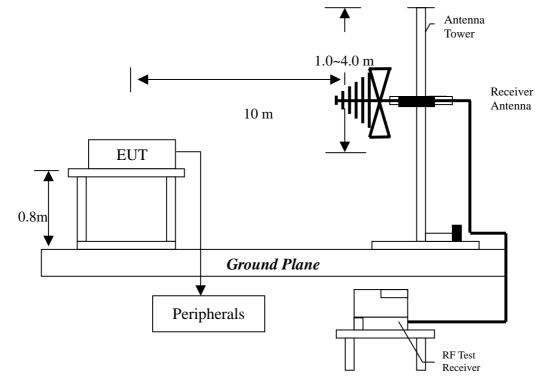
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5. EN 55022 Radiated Emission Test

5.1 Operating Environment

Temperature:	25		Atmospheric Pressure: 1023	hPa
Relative Humidity:	55	%	Test Voltage: 230Vac, 50Hz	

5.2 Test Procedure



Radiated testing was performed at a 10 meters open area test site. The equipment under test were placed on a turntable top 0.8 m above ground. The table was 360 degrees to determine the position of the highest radiation. EUT is set 10 meters from the EMI receiving antenna, which is mounted on a variable height mast. The antenna height is varied between one meter and four meters above ground to find the maximum value of the field strength. Both horizontal polarization and vertical polarization of the antenna was set to conduct the measurement.

The bandwidth was set on the EMI meter 120 kHz.

The levels are quasi peak value readings. The frequency spectrum from 30 MHz to 1000 MHz was investigated.



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5.3 Test Equipment

Equipment	Brand	Model No.	Intertek ID No.	Next Cat. Date
EMI Receiver	Rohde & Schwarz	ESCS 30	EC346	07/24/2007
Turn Table	Electro-Metrics	EM4710	EP306	N/A
Bilog Antenna	Schaffner	CBL6112B	EC367	03/16/2008
Ferrite Clamp	Rohde & Schwarz	EZ-24	N/A	N/A

Note: The above equipments are within the valid calibration period.

5.4 Radiated Emission Limit

Frequency (MHz)	Distance(m)	Class A(dB µ V/m)	Class B(dB µ V/m)
30~230	10	40	30
230~1000	10	47	37

Note:

1. The tighter limit shall apply at the edge between two frequency bands.

2. Distance refers to the distance in meters between the EUT to antenna.

5.5 Uncertainty of Radiated Emission

Expanded uncertainty (k=2) of radiated emission measurement is ± 4.68 dB.



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5.6 Radiated Emission Test Data

Polarity:	Vertical
Model No.:	RU-87P SERIES
Test Condition:	Normal operating mode

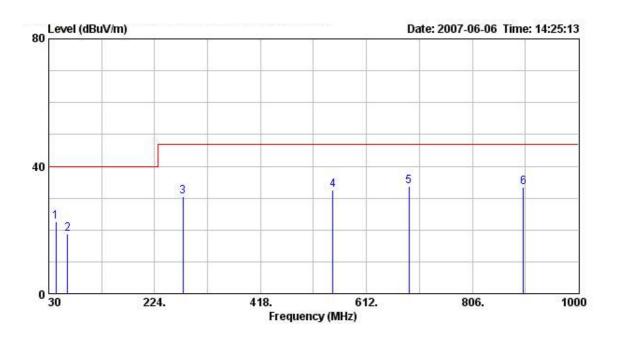
Freq	Pol/Phase	Factor	Read Level	Level	Limit Line	Over Limit	Remark
Mtz	,;	dB	dBuV	dBuV/m	dBuV/m	dB	-
43.60	VERTICAL	12.24	10.30	22.54	40.00	-17.46	QP
64.90	VERTICAL	7.46	11.30	18.76	40.00	-21.24	QP
275.77	VERTICAL	15.13	15.30	30.43	47.00	-16.57	QP
550.29	VERTICAL	22.24	10.20	32.44	47.00	-14.56	QP
690.10	VERTICAL	22.64	11.10	33.74	47.00	-13.26	QP
899.10	VERTICAL	24.87	8.60	33.47	47.00	-13.53	QP

Remark:

1. Level (dB μ V/m)= Factor (dB/m)+ Read Level (dB μ V)

2. Factor = Antenna Factor (dB/m) + Cable Loss (dB)

3. Over Limit (Margin) (dB) = Level (dB μ V/m) – Limit Line(dB μ V/m)





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Polarity:	Horizontal
Model No.:	RU-87P SERIES
Test Condition:	Normal operating mode

Freq	Pol/Phase	Factor	Read Level	Level	Limit Line	Over Limit	Remark
MHz		dB	dBuV	dBuV/m	dBuV/m	dB	-
43.60	HORI ZONTAL	12.24	12.30	24.54	40.00	-15.46	QP
43.60	HORI ZONTAL	12.24	18.20	30.44	40.00	-9.56	QP
441.30	HORI ZONTAL	19.58	8.90	28.48	47.00	-18.52	QP
485.90	HORI ZONTAL	20.34	9.50	29.84	47.00	-17.16	QP
550.60	HORI ZONTAL	22.24	10.20	32.44	47.00	-14.56	QP
690.50	HORI ZONTAL	22.64	9.50	32.14	47.00	-14.86	QP
830.20	HORI ZONTAL	24.29	11.20	35.49	47.00	-11.51	QP

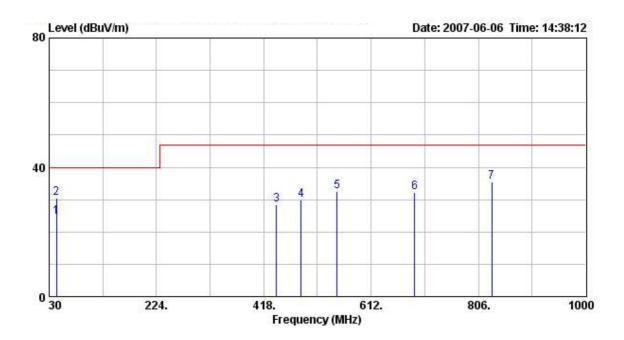
Remark:

-

1. Level (dB μ V/m)= Factor (dB/m)+ Read Level (dB μ V)

2. Factor = Antenna Factor (dB/m) + Cable Loss (dB)

3. Over Limit (Margin) (dB) = Level (dB μ V/m) – Limit Line(dB μ V/m)





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6. EN 61000-3-2 Harmonics

6.1 Operating Environment

Temperature:	25		Atmospheric Pressure:	1023	hPa
Relative Humidity:	55	%	Test Voltage:	230Vac	, 50Hz

6.2 Test Procedure

Harmonics of the fundamental current were measured up to 2 kHz using a digital power analyzer. The test voltage was supplied from an AC source, which meets the requirements according to the standard.

The steady-state harmonic current measurements were carried out using averaging.

The transitory harmonics were measured during an observation period of 2.5 minutes. The disturbance duration time (limit 15 s) is defined as the total time under which the transitory harmonics exceeds the limit level for steady-state harmonics during an observation period of 2.5 minutes.

6.3 Test Equipment

Equipment	Brand	Model No.	Intertek ID No.	Next Cal. Date
EMC Emission Tester	EMC Partner	HARMONICS-1000	EC364	12/18/2007

Note: The above equipments are within the valid calibration period.

6.4 Uncertainty of Radiated Emission

Expanded uncertainty (k=2) of radiated emission measurement is ± 0.2 dB.



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6.5 Test Result

EUT: RU-87P SERIES

CLASSIFICATION: CLASS A SUMMARY RESULT: PASS

Harmonic Current Results

Hn	AMPs	Current Limit	Result
1	0.144	NaN	Pass
2	0.075	1.080	Pass
3	0.027	2.300	Pass
4	0.023	0.430	Pass
5	0.023	1.140	Pass
6	0.016	0.300	Pass
7	0.014	0.770	Pass
8	0.010	0.230	Pass
9	0.009	0.400	Pass
10	0.007	0.184	Pass
11	0.007	0.330	Pass
12	0.006	0.153	Pass
13	0.006	0.210	Pass
14	0.005	0.131	Pass
15	0.005	0.150	Pass
16	0.005	0.115	Pass
17	0.005	0.132	Pass
18	0.005	0.102	Pass
19	0.004	0.118	Pass
20	0.004	0.092	Pass

		Current	
Hn	AMPs	Limit	Result
21	0.004	0.107	Pass
22	0.004	0.084	Pass
23	0.004	0.098	Pass
24	0.003	0.077	Pass
25	0.003	0.090	Pass
26	0.003	0.071	Pass
27	0.003	0.083	Pass
28	0.003	0.066	Pass
29	0.003	0.078	Pass
30	0.003	0.061	Pass
31	0.003	0.073	Pass
32	0.002	0.058	Pass
33	0.002	0.068	Pass
34	0.002	0.054	Pass
35	0.002	0.064	Pass
36	0.002	0.051	Pass
37	0.002	0.061	Pass
38	0.002	0.048	Pass
39	0.002	0.058	Pass
40	0.002	0.046	Pass

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7. EN 61000-3-3 Voltage Fluctuations-Flicker

7.1 Operating Environment

Temperature: 25		Atmospheric Pressure:	1023	hPa	
Relative Humidity:	56	%	Test Voltage:	230Vac	, 50Hz

7.2 Test Procedure

The voltage changes at the supply terminals were measured using the voltage method.

The test voltage was supplied from an AC source which meets the requirements according to the standard. The voltage source has virtually zero internal impedance and is connected

(1 phase) Z = 0.4 + j 0.25 (total impedance)

(3 phases) Impedance in line conductor: Za = 0.25 + j 0.25Impedance in neutral conductor: Zn = 0.15 + j 0.10

The short-term flicker P_{st} is measured during a time interval of 10 minutes. The long-term flicker P_{lt} is evaluated from 12 subsequently measured short-term flicker values.

24 measurement have been tasted and calculated the average from 22 records, exclude highest and lowest.

7.3 Test Equipment

Equipment	Brand	Model No.	Intertek ID No.	Next Cal. Date
EMC Emission Tester	EMC Partner	HARMONICS-1000	EC364	12/18/2007

Note: The above equipments are within the valid calibration period.

7.4 Uncertainty of Radiated Emission

Expanded uncertainty (k=2) of radiated emission measurement is ± 0.47 dB.



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7.5 Test result

EUT: RU-87P SERIES

SUMMARY RESULT:

PASS

TEST CONDITIONS:

STANDARD TEST CONDITIONS

	EUT DATA	LIMIT	RESULT	TEST ENABLED
Pst max	0.087	1.00	PASS	
Plt max	0.075	0.65	PASS	
d _c %	0.26	3.30	PASS	
d _{max} %	0.33	4.00	PASS	X
d _(t) Sec.	0.00	0.50	PASS	

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8. IEC 61000-4-2 Electrostatic Discharge Immunity Test

8.1 Operating Environment

Temperature:	25		Atmospheric Pressure:	1023	hPa
Relative Humidity:	55	%	Test Voltage:	230Va	c, 50Hz

8.2 Purpose

The object of the test is to evaluate the ESD immunity performance of EUT.

8.3 Test Set-Up

A horizontal coupling plane (HCP) was placed on a non-metallic table 0.8 m above a reference ground plane (RGP) and connected to it with a cable with two 470 k resistors. The EUT was placed on an insulation sheet on the HCP and was operated according to the specified operating mode.

A vertical coupling plane (VCP) was connected to the RGP with a cable with two 470 k resistors.

8.4 Test Conditions

Test level:	Air discharge	 +/- 8kV
	Contact discharge	 +/- 4kV

Single discharge at 1 second interval positive discharge and negative discharge



8.5 Test Equipment

Equipment	Manufacturer	Model No.	Intertek ID No.	Next Cal. Date
Electrostatic Discharge System	NoiseKen	ESS-2002	EC362	09/24/2007

Note: The above equipments are within the valid calibration period.

8.6 Test Result

Point of Discharge	Applied Voltage (kV)	Total No. of Discharge (Each Point)	Result	Criteria Level	Remark
Countrast Trast Daint	±2	25	Р	А	-
Contact Test Point	<u>+</u> 4	25	Р	А	-
	±2	20	Р	А	-
Air Test Point	<u>+</u> 4	20	Р	А	-
	± 8	20	Р	А	-
VCP	±2	25	Р	А	-
(4 sides)	<u>+</u> 4	25	Р	А	-
НСР	±2	25	Р	А	-
(4 sides)	<u>+</u> 4	25	Р	А	-

Description

Contact Discharge	Air Discharge
Metallic Screws	Plastic Screws
Metallic Case	Plastic Case (gap)
Metallic Connect ports	Plastic Connect ports
Metallic Junctions	Plastic Junctions
Others:	LED indicator
	Panel Board
	Others:

Note: 1. "P" means the EUT pass the test.

Note: 2. "-" means not applicable

 \boxtimes Meet criterion A – operated as intended during and after the test

Meet criterion B – operated as intended after the test

Meet criterion C - loss/error of function



9. IEC 61000-4-3 Radiated, Radio-Frequency, Electromagnetic Field Immunity Test

9.1 Operating Environment

Temperature:	23		Atmospheric Pressure:	1023	hPa
Relative Humidity:	53	%	Test Voltage:	230Vac	, 50Hz

9.2 Purpose

This test method subjects the EUT to a power source of disturbance comprising electric and magnetic field, simulating those coming from intentional RF transmitters.

9.3 Test Set-Up

The EUT was placed on a non-metallic table 0.8 m above the reference ground plane (RGP) and was operated according to its specified operating mode.

Ferrite tiles/absorbers were placed on the RGP between the EUT and the antenna to reduce the reflections from the RGP. The EUT and its cables were exposed for the electromagnetic field for 1.5m vertically and 1.5m horizontally.

The distance between antenna and EUT is 3 meter.

9.4 Test Conditions

Test level	Test field strength V/m	Modulation
1	1	1 kHz 80% AM
2	3	1 kHz 80% AM
3	10	1 kHz 80% AM
X	Special	1 kHz 80% AM

The frequency steps	: 1 %, Log sweep
Dwell time	: 3 sec
Frequency range	: 80MHz~1GHz
Test ports	: Enclosure port
Test field strength	: 3V/m



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9.5 Test Equipment

Equipment	Manufacture	Model No.	Intertek ID No.	Next Cal. Date
An-echoic chamber 7m×3m×3m	Comtest Instrumentation	9708093	EC328	02/12/2008
RF signal Generator	Marconi	2024	EC301	08/08/2008
Dual Band RF Power Amplifier	Kalmus	757LCB	EP314	N/A
High Power Microwave Amplifier Series	MILMEGA	AS0102-30	EP318	N/A
Bi-log Antenna	EMCO	3141	EP386	N/A
RF Power Meter	Boonton	4230	EC302	08/08/2008
Power Sensor	Boonton	51011-EMC	EC302-1	08/08/2008
Power Sensor	Boonton	51011-EMC	EC302-2	08/08/2008
Field Probe	Holaday	HI-4422	EC307	11/15/2007

Note: The above equipments are within the valid calibration period.

9.6 Generation of The Electromagnetic Field

The electromagnetic field is generated from a computer controlled signal generator. The output power is amplified and then radiated from broadband log periodic antennas. For each sweep a pre-recorded empty chamber calibration file is used to establish the required field strength. When using these files the field strength inside an area of 1.5/1.0 m x 1.5 m is in accordance with the standard.



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9.7 Test Results

Exposed Side: I Front I Left I Rear I Right

H: Horizontal V: Vertical

Frequency (MHz)	Horizontal/ Vertical	Result	Criteria Level	Remark
80MHz to 1GHz	Н	Р	А	-
80MHz to 1GHz	V	Р	А	-

Note: 1. "P" means the EUT pass the test.

Note: 2. "-" means not applicable

 \boxtimes Meet criterion A – operated as intended during and after the test

Meet criterion B – operated as intended after the test

Meet criterion C - loss/error of function

Intertek ETL SEMKO

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10. IEC 61000-4-4 Electrical Fast Transient/Burst Immunity Test

10.1 Operating Environment

Temperature:	25		Atmospheric Pressure:	1023	hPa
Relative Humidity:	55	%	Test Voltage:	230Va	c, 50Hz

10.2 Purpose

The purpose of this test is to evaluate the EUT performance during the repetitive transient bursts applied to power port and ports for I/O ports.

10.3 Test Set-Up

For power port testing, the EUT was placed on a non-metallic table 0.1 m above a reference ground plane (RGP) and was put into operation according to the specified operating mode.

10.4 Test Condition

Open-circuit output test voltage ($\pm 10\%$) and repetition rate of the impulses ($\pm 20\%$)						
	On power su	On power supply port, PE		Output) signal, ontrol ports		
Level	Voltage peak	Repetition rate	Voltage peak	Repetition rate		
	kV	kHz	kV	kHz		
1	0.5	5 or 100	0.25	5 or 100		
2	1	5 or 100	0.5	5 or 100		
3	2	5 or 100	1	5 or 100		
4	4	5 or 100	2	5 or 100		
X ⁽¹⁾	Special	Special Special		Special		
NOTE 1 Use of 5 kHz repetition rates is traditional; however, 100 kHz is closer to reality. Product committees should determine which frequencies are relevant for specific products or product types. NOTE 2 With some products, there may be no clear distinction between power ports and I/O ports, in which case it is up to product committees to make this determination for test purposes. (1) "x" is an open level. The level has to be specified in the dedicated equipment specification						



10.5 Test Equipment

Equipment	Manufacture	Model No.	Intertek ID No.	Next Cal. Date
EFT/Burst Tester	EFT/Burst Tester Keytek		EC312	08/07/2008

Note: The above equipments are within the valid calibration period.

10.6 Test Results

Level	Polarity	Power supply line and Protective earth terminal	Signal Line & Control Line	Criteria Level
0.25kV	+	-	-	-
0.25kV	-	-	-	-
0.5kV	+	-	-	-
0.5kV	-	-	-	-
1kV	+	Р	-	А
1kV	-	Р	_	А
2kV	+	-	-	-
2kV	-	-	-	-

Note: 1. "P" means the EUT pass the test. Note: 2. "-" means not applicable

Meet criterion A - operated as intended during and after the test

Meet criterion B - operated as intended after the test

Meet criterion C - loss/error of function



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11. IEC 61000-4-5 Surge Immunity Test

11.1 Operating Environment

Temperature:	25		Atmospheric Pressure:	1023 hPa
Relative Humidity:	55	%	Test Voltage:	230Vac, 50Hz

11.2 Purpose

The object of this test is to establish a common reference to evaluate the performance of EUT when subjected to high-energy disturbances on the power and interconnection lines.

11.3 Test Set-Up

The EUT was placed on a non-metallic support 0.8 m above a reference ground plane and was put into operation according to the specified operating mode.

11.4 Test Conditions

For power suppry fille		
Level	Open circuit test voltage kV +/- 10%	Remark
1	0.5	L1 to L2
2	1.0	L1 to Gnd L2 to Gnd
3	2.0	L1 to Gnd L2 to Gnd
4	4.0	-
X	Special	-
	•	•

For power supply line

Note: "X" is an open class. This level can be specified in the product specification

Surge wave form: 1.2 x 50 µs, Repetition rate: 1 /min (max)

For signal line: applicable only to ports which according to the manufacturer's specification may connect directly to outdoor cable

Level	Open circuit test voltage kV +/- 10%	Remark	
2	1.0	Line to Ground	

Surge wave form: $1.2 \times 50 \mu s$, Repetition rate: 1 / min (max)



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11.5 Test Equipment.

Equipment	Manufacture	Model No.	Intertek ID No.	Next Cal. Date
Surge Tester	Key Tek	EMC Pro	EC313	10/18/2007
External Coupler/Decoupler for Telecom Line	Key Tek	CM-TELCD	EP326-1	N/A

Note: The above equipments are within the valid calibration period.

11.6 Test Results

11.6.1 Main power ports

Test 5 times for each voltage

Phase		0^{o}	90°	180°	270°	Criteria	
Volt	Mode	Polarity	0	90	100	270	level
0.5kV	L1 to L2	+	Р	Р	Р	Р	А
0.3K V	L1 10 L2	-	Р	Р	Р	Р	А
1kV	L1 to L2	+	Р	Р	Р	Р	А
IKV LI to L2	-	Р	Р	Р	Р	А	
	L1 to Gnd	+	Р	Р	Р	Р	А
1kV/2kV		-	Р	Р	Р	Р	А
	L2 to Gnd	+	Р	Р	Р	Р	А
	L2 10 Ollu	-	Р	Р	Р	Р	А

Note: 1. "P" means the EUT pass the test. Note: 2. "-" means not applicable

Meet criterion A - operated as intended during and after the test

Meet criterion B - operated as intended after the test

Meet criterion C - loss/error of function



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12. IEC 61000-4-6 Immunity to Conducted Disturbances, Inducted by Radio-Frequency Fields

12.1 Operating Environment

Temperature:	25	°C	Atmospheric Pressure:	1023	hPa
Relative Humidity:	55	%	Test Voltage:	230Vac	, 50Hz

12.2 Purpose

The test method subjects the EUT to a power source of disturbance comprising electric and magnetic field, simulating those coming from intentional RF transmitters. The measurement is for evaluating the performance of EUT when subjected to RF conducted disturbance.

12.3 Test Set-Up

The EUT was placed on a non-metallic support 0.1 m above a reference ground plane (RGP) with the coupling/decoupling network (CDN) placed 0.3 m from the EUT on the RGP.

12.4 Test Conditions

Test level	Voltage (Vrms)	Modulation
1	1	1 kHz 80% AM
2	3	1 kHz 80% AM
3	10	1 kHz 80% AM
X	Special	1 kHz 80% AM

The frequency steps	: 1 %, Log sweep
Dwell time	: 3 sec
Frequency range	: 150kHz to 80MHz
Test ports	: AC por
Test voltage	: 3Vrms



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12.5 Test Equipment

Equipment	Manufacture	Model No.	Intertek ID No.	Next Cal. Date
RF signal Generator	Marconi	2024	EC301	08/08/2007
RF-Generator	SCHAFFNER	NSG2070	EC358	11/27/2007
Dual Band RF Power Amplifier	Kalmus	757LCB	EP314	N/A
Coupling Decoupling Network	Comtest instrument	4412-016	EC305	11/15/2007
Coupling Decoupling Network	Comtest instrument	4413-016	EC306	11/15/2007
Coupling Decoupling Network	SCHAFFNER	CDN T400	EC385	11/15/2007
RF Injection Clamp	Luthi	EM101	EC308	11/15/2007
RF Power Meter	Boonton	4230	EC302	08/08/2007
Power Sensor	Boonton	51011-EMC	EC302-1	08/08/2007
Power Sensor	Boonton	51011-EMC	EC302-2	08/08/2007

Note: The above equipments are within the valid calibration period.

12.6 Generation And Calibration of The Disturbance Signal

The disturbance signal is generated from a computer controlled signal generator. The output signal is amplified and injected to the CDN/injection clamp. The disturbance signal level was calibrated as specified in the standard. A power meter was connected to the EUT side of the CDN through a 150 -50 adapter. The auxiliary equipment (AE) side of the network was terminated with 150 to ground during the calibration. The generator settings obtained during the calibration procedure were later repeated in the tests.



12.7 Test Results

Frequency (MHz)	Test Port/Line	Result	Criteria Level	Remark
0.15MHz to 80MHz	Power Line	Р	А	-

Note: 1. "P" means the EUT pass the test. Note: 2. "-" means not applicable

Meet criterion A – operated as intended during and after the test

Meet criterion B – operated as intended after the test

Meet criterion C – loss error of function



13. IEC 61000-4-11 Voltage Dips, Short Interruptions and Voltage Variations Immunity Test

13.1 Operating Environment

Temperature:	25		Atmospheric Pressure:	1023	hPa
Relative Humidity:	55	%	Test Voltage:	230Va	c, 50Hz

13.2 Purpose

The object of this standard is to establish a common reference for evaluating the immunity of electrical and electronic equipment when subjected to voltage dips, short interruptions, and voltage variations.

13.3 Test Set-Up

The EUT was placed on a non-metallic support 0.8 m above a reference ground plane and was put into operation according to the specified operating mode.

13.4 Test Condition

Reduction '% of rated	Test Level % U _T	Duration (Period)	Tests	Recovery Time
>95% Dip	0% Short Circuit	0.5	3	10 Sec.
>95% Dip	0% Open Circuit	0.5	3	10 Sec.
30% Dip	70%	25	3	10 Sec.

Test Level % U _T	Duration (Period)	Tests	Recovery Time
0% Short Circuit	250	3	10 Sec.
0% Open Circuit	250	3	10 Sec.



13.5 Test Equipment

Equipment	Manufacturer	Model No.	Intertek ID No.	Next Cal. Date
Dip Tester	Keytek	EMC Pro	EC313	11/21/2007

Note: The above equipments are within the valid calibration period.

13.6 Generation of The Disturbance Signal

The disturbance signal is generated using a programmable AC power source with pre-programmed test sequences for each test.

13.7 Test Result

I. Dip of mains voltage

Test Level	Reduction '% of rated	Test Level % U _T	Duration (Period)	Tests	Recovery Time	Criteria Level
1	>95% Dip	0% Short Circuit	0.5	3	10 Sec.	А
1	>95% Dip	0% Open Circuit	0.5	3	10 Sec.	А
2	30% Dip	70%	25	3	10 Sec.	А

II. 0 % of mains voltage

Test Item	Test Level % U _T	Duration (Period)	Tests	Recovery Time	Criteria Level
1	0% Short Circuit	250	3	10 Sec.	В
2	0% Open Circuit	250	3	10 Sec.	В

Meet criterion A - operated as intended during and after the test

 \boxtimes Meet criterion B – operated as intended after the test

Meet criterion C – loss error of function



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Appendix A1: External photo of EUT







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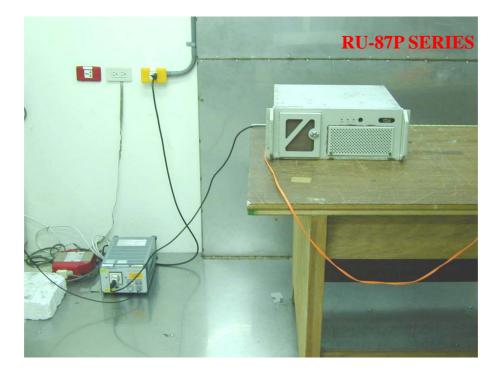
Appendix A2: Internal photo of EUT





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Appendix B1: Conducted Emission Test Set-up







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Appendix B2: Radiated Emission Test Set-up



